

# APPROVAL SHEET

# WLPN242410 Series Shielded SMD Power Inductors

\*Contents in this sheet are subject to change without prior notice.

#### Approval sheet

#### Features

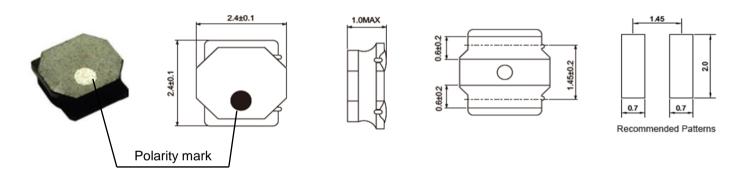
- 1. Close magnetic loop with magnetic resin shielded.
- 2. Low profile, High inductance.

#### Applications

- 1. General propose power inductor in DC power system.
- 2. Inductor in DC/DC converter.
- 3. Low profile for portable and wearable device.
- 4. LC filter in Audio D class Amplifier.

#### Shape and Dimension

Unit: mm



#### **Ordering Information**

WL	PN	2424	10	Ν	R68	Р	В
Product Code	Series	Dimensions	Thickness	Tolerance	Value	Packing Code	
WL: Inductor	Shielded SMD Power Inductors	2.4 * 2.4 mm	1.0 mm	M: ± 20% N: ± 30%	R68 = 0.68uH 2R2 = 2.2uH 100 = 10uH	P=7" Reeled (Embossed Tape)	B:STD

#### **Electrical Characteristics**

	L	Inductance	Test Freq			Rated Current (mA) Max	
WLPN242410				DCR	SRF		
Series	(uH)	Tolerance	(KHz)	(Ω ± 20%)	(MHz)Min	Saturation Current Idc1	Temperature Rise Current Idc2
WLPN242410NR68PB	0.68	±30%	100	0.06	120	2200	1570
WLPN242410N1R0PB	1.0	±30%	100	0.07	106	1800	1410
WLPN242410M1R5PB	1.5	±20%	100	0.11	94	1550	1160
WLPN242410M2R2PB	2.2	±20%	100	0.15	77	1290	970
WLPN242410M3R3PB	3.3	±20%	100	0.22	56	1000	770
WLPN242410M4R7PB	4.7	±20%	100	0.29	50	880	670
WLPN242410M6R8PB	6.8	±20%	100	0.41	43	750	570
WLPN242410M100PB	10	±20%	100	0.69	32	550	450
WLPN242410M150PB	15	±20%	100	1.02	27	470	370
WLPN242410M220PB	22	±20%	100	1.47	22	390	300

1. Test Frequency: 100KHz.

2. Test Equipment:

Inductance: Chroma3302+1320+16502 or equivalent. DCR: Chroma16502 or equivalent. SRF: HP4291B or equivalent.

3. Saturation Current Idc1: The value of current causes a 30% inductance reduction from initial value.

4. Temperature rise current ldc2: The value of current causes a 40  $^\circ\!C$  temperature rise.

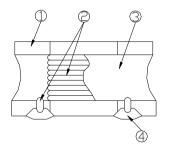
5. Rated Current: Either Idc1 or Idc2 whichever is smaller.

6. Operating Temperature Range:-25℃ to +120℃ (Including self-temperature rise).

7. Storage Temp. Range :  $-40^{\circ}$ C to  $+85^{\circ}$ C.

8. MSL : Level 1.

# **Structural Drawing**

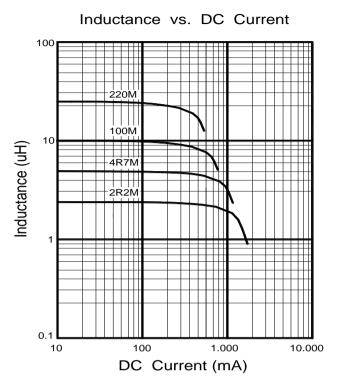


- ① Ferrite core : Ni-Zn ferrite.
- ② Winding wire : Polyurethane-copper wire.
- ③ Over-coating resin : Epoxy resin, containing ferrite powder.
- ④ Electrode : External electrode (substrate) Cu.

External electrode (top surface solder coating) Sn-Ag-Cu.

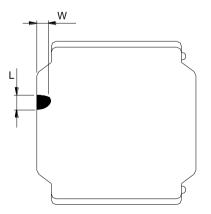


## **Characteristic Curve**



# **Core Chipping:**

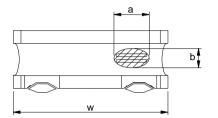
The appearance standard of the chipping size in top side, of bottom side ferrite core is following dimension.



L	W				
0.5mmMax.	0.5mmMax.				

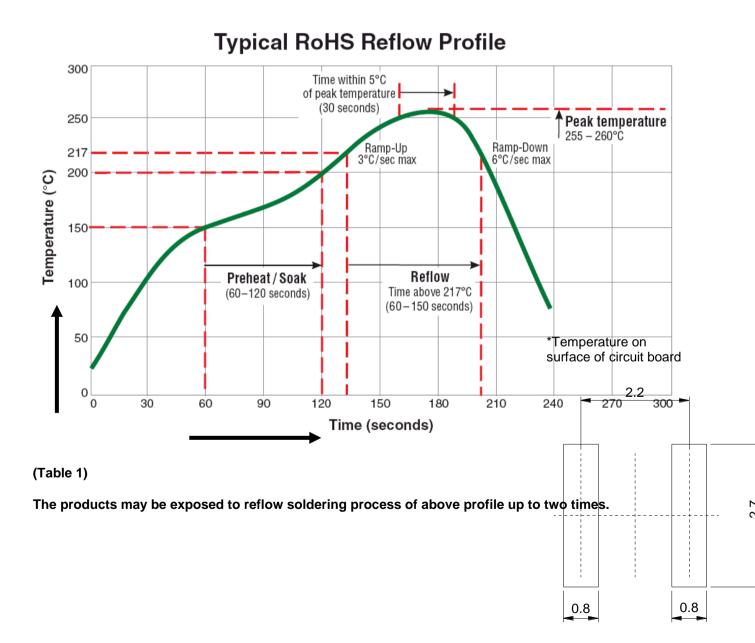


# Exposed wire tolerance limit of coating resin part on product side Size of exposed wire occurring to coating resin is specified below.



- ① Width direction (dimension a): Acceptable when a<=w/2 Nonconforming when a>w/2
- ② Length direction (dimension b): Dimension b is not specified.
  ③ When total area of exposed wire occurring to each sides is
  - not greater than 50% of coating resin area, that is acceptable.

# **Reflow Profile Chart (Reference):**



### Mechanical Performance /Environmental Test Performance Specifications: (WLPN242410 series)

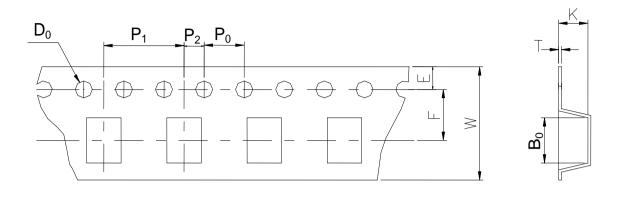
No.	ltem	Test condition	Requirements					
	Resistance to Deflection.	No damage.	The test samples shall be soldered to the test board by the reflow soldering conditions show in Table 1. As illustrated below, apply force in the direction of the Arrow indicating until deflection of the test board Reaches to 2 mm.					
1			R5 $45\pm2$ $45\pm2$ $45\pm2$ $5.1$ $5.1$ $5.1$ $5.1$ $7$ $7$ $7$ $7$ $7$ $7$ $7$ $7$ $7$ $7$					
			Land dimensionsTest board size :100×40×10Unit: mmTest board material I: glass epoxy-resinSolder cream thickness:0.1					
	Adhesion of Terminal Electrode.	Shall not come off PC board.	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1. 10  N, 5  s					
2			Applied force: 10 N to X and Y directions Duration: 5 s. Solder cream thickness:0.1 mm. (Refer to recommended Land Pattern Dimensions Defined in "Precaution")					
	Body strength.	No damage.	Applied force :20 N. Duration :10 s.					
3								
	Resistance to Vibration.	△L/L:within±10% No abnormality observed In	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.Then it shall be submitted to below test conditions.					
4		appearance.	Frequency range     10Hz~55Hz					
4			Total Amplitude1.5mm(May not exceed acceleration 196 m/S2)Sweeping Method10Hz to 55Hz to 10 Hz for 1 min.					
			Sweeping MethodTon 2 to 3512 to 10112 to					
5	Resistance to Soldering heat (Reflow).	△L/L:within±10% No abnormality observed In appearance.	The test sample shall be exposed to reflow oven at 230±5 deg C for 40 seconds, with peak temperature at 260±5 deg C for 5 seconds, 2 times. Test board thickness: 1.0 mm. Test board material: glass epoxy-resin.					

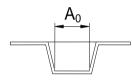
	Solder ability.	At least 90% of surface of terminal	molten s	t samples shall older as shown	in below	table.	hen Immerse	d in	
c		electrode is covered by new		thanol solution	containing rosin 25%. 245±deg C		7		
6		solder.	Colder	Time	5±1.0 S.				
			Imme	ersing Speed		5 mm/s			
7	Temperature Characteristics.	△L/L:within±20% No abnormality observed in appearance.	-25 deg	ment of inducta C to +85 deg C. erence to induct ed.				_	
	Thermal shock.	△L/L:within±10% No abnormality observed in appearance.	The test samples shall be soldered to test board by the reflow soldering conditions shown in Table 1. The test samples shall be placed at specified shown in below table in sequence. The temperature cycle shall be repeated 100 cycles.						
8				ns of steps for 1					
			Step	Temperat		Time(r			
			1	-40±3 deg	-	30±			
				2 Room Temp			3 maximum 30±3		
			3		85±2 deg C Room Temp				
	Low	$\triangle$ L/L:within±10%	4         Room Temp         3 maximum           The test samples shall be soldered to the test board by the reflo				eflow		
9	Temperature life Test.	No abnormality observed in appearance.	ty soldering conditions shown in Table 1. After that, the test samples shall be placed at test conditions as in below table.						
			Ten						
10	Loading at high temperature life test.	△L/L:within±10% No abnormality observed in appearance.	soldering The test	samples shall b g conditions sho samples shall b ture and applied ble.	own in Tab be placed	ble 1. in thermostat	ic oven set at	specified	
10			Ter	nperature	85±	2 deg C			
			Appl	ied current		d current to Page 3)			
				Time		⊦24/-0 h			
11	Damp heat life test.	△L/L:within±10% No abnormality observed in appearance.	<ul> <li>The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.</li> <li>The test samples shall be placed in thermostatic oven set at specified temperature and humidity as shown in below table.</li> <li>Temperature</li> <li>60±2 deg C</li> </ul>						
			F	lumidity	90~	95%RH			
				Time	500-	⊦24/-0 h			
12	Loading under Damp heat life test.	△L/L:within±10% No abnormality observed in appearance.	ormality soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specifie						
12				lumidity		90~95%RH			
				lied current	Rated c	urrent (Refer t			
				Time	500+24/-0 h				
						500.21701			

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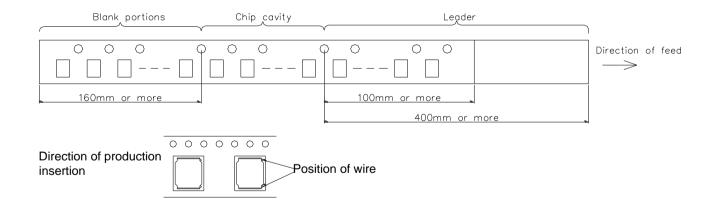
# Tape & Reel Packaging Dimensions: Dimensions Unit: mm





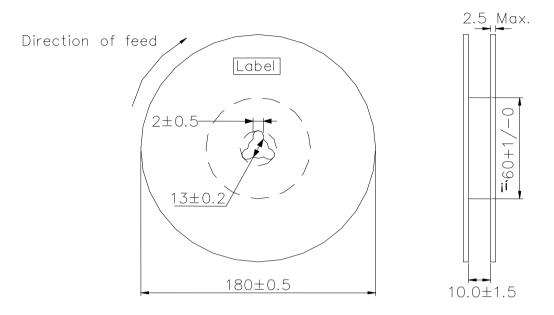
Ao	Bo	W	F	Е	<b>P</b> 1	<b>P</b> <sub>2</sub>	P٥	Do	Т	K
2.6 ±0.1	2.6 土0.1	8.0 ±0.2	3.5 ±0.1	1.75 ±0.1	4.0 ±0.1	2.0 ±0.05	4.0± 0.1	Ф1.5 +0.1 -0	0.25 ±0.05	1.3 ±0.1

#### **Direction of rolling**



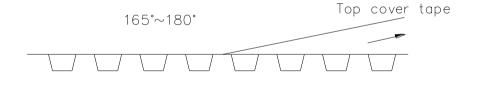


#### Reel



Label position:on the opposite sie of sprocket holes side of reel

Top tape strength



Peel-off strength: 0.1N~0.7N Peel-off angle:165°~180° Peel-off speed: 300mm/mm

Quantity per reel : 2.5K pcs